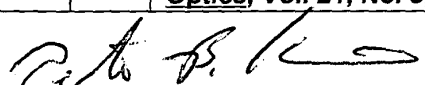


PATENT & TRADEMARK OFFICE 001
OCT 30 2000

Sheet 1 of 1 FORM PTO 1449 (modified) U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary) Date Submitted to PTO: October 30, 2000				ATTY DOCKET NO. 684.2700 CIP		APPLICATION NO. 09/523,735	
				APPLICANT YASUYUKI UNNO			
				FILING DATE March 13, 2000		GROUP 2851	
U.S. PATENT DOCUMENTS							
*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
PK		5,880,891	03/1999	Furter	359	651	
PK		5,805,273	09/1998	Unno	355	30	
PK		5,696,628	12/1997	Sutton, et al.	359	566	
PK		5,627,676	05/1997	Borrelli, et al.	359	494	
PK		5,459,000	10/1995	Unno	430	5	
PK		5,184,176	02/1993	Unno, et al.	355	52	
PK		5,142,548	08/1992	Krasinski, et al.	372	105	
PK		5,117,433	05/1992	Tatsuno, et al.	372	22	
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT
PK		8-107060	04/1996	Japan			Abstract
OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)							
PK		E. Mochida, "Optical Technique Contact", Vol. 27, No. 3 (1989), p. 127-134.					
PK		M. Born, et al., "Principles of Optics", 1st Ed., Pergamon Press, New York, pp. 705-708 (1959).					
PK		Aoyama, et al., "Form Birefringence Using Ultra-High Spatial Frequency Gratings", Optics, Vol. 21, No. 5, pp. 269-274 (1992).					
EXAMINER 				DATE CONSIDERED 8/1/01			

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.